

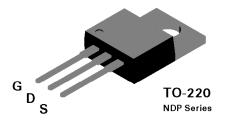
NDP7061L / NDB7061L N-Channel Logic Level Enhancement Mode Field Effect Transistor

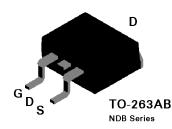
General Description

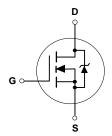
These logic level N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulses in the avalanche and commutation modes. These devices are particularly suited for low voltage applications such as automotive, DC/DC converters, PWM motor controls, and other battery powered circuits where fast switching, low in-line power loss, and resistance to transients are needed.

Features

- 60 A, 60 V. $R_{DS(ON)}$ = 0.018 Ω @ V_{GS} = 5 V $R_{DS(ON)}$ = 0.013 Ω @ V_{GS} = 10 V.
- Low drive requirements allowing operation directly from logic drivers. V_{GS(TH)} < 2.0V.
- Rugged internal source-drain diode can eliminate the need for an external Zener diode transient suppressor.
- 175°C maximum junction temperature rating.
- High density cell design for extremely low R_{DS(ON)}.
- TO-220 and TO-263 (D²PAK) package for both through hole and surface mount applications.







Absolute Maximum Ratings T_c = 25°6

С	=	25	C	unless	otherwise	noted

Symbol	Parameter	NDP7061L	NDB7061L	Units		
V _{DSS}	Drain-Source Voltage	60				
V_{DGR}	Drain-Gate Voltage ($R_{GS} \le 1 \text{ M}\Omega$)	60				
V_{GSS}	Gate-Source Voltage - Continuous	±	16	V		
	- Nonrepetitive (t _P < 50 μs)	± 25				
I _D	Drain Current - Continuous	60				
	- Pulsed	180				
P _D	Maximum Power Dissipation @ T _C = 25°C	1	30	W		
	Derate above 25°C	0	.87	W/°C		
T _J ,T _{STG}	Operating and Storage Temperature Range	-65	to 175	°C		

Symbol	Parameter	Conditions	Min	Тур	Max	Units	
DRAIN-S	OURCE AVALANCHE RATINGS (Note 1)						
W _{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 30 \text{ V}, I_{D} = 60 \text{ A}$				500	mJ
I _{AR}	Maximum Drain-Source Avalanche Curr	ent				60	Α
OFF CHA	ARACTERISTICS						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		60			V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}$				10	μΑ
			T _J = 125°C			1	mA
I _{GSSF}	Gate - Body Leakage, Forward	$V_{GS} = 16 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
I _{GSSR}	Gate - Body Leakage, Reverse	$V_{GS} = -16 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
ON CHAI	RACTERISTICS (Note 1)						
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		1	1.2	2	V
			T _J = 125°C	0.65	0.7	1.5	
R _{DS(ON)}	Static Drain-Source On-Resistance	$V_{GS} = 5 \text{ V}, I_{D} = 30 \text{ A}$			0.013	0.018	Ω
			T _J = 125°C		0.023	0.032	
		$V_{GS} = 10 \text{ V}, I_{D} = 30 \text{ A}$			0.011	0.013	
I _{D(on)}	On-State Drain Current	$V_{GS} = 5 \text{ V}, V_{DS} = 10 \text{ V}$		60			Α
g _{FS}	Forward Transconductance	$V_{DS} = 10 \text{ V}, I_{D} = 30 \text{ A}$			45		S
DYNAMI	C CHARACTERISTICS						
C _{iss}	Input Capacitance	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		2600		pF	
C _{oss}	Output Capacitance	f = 1.0 MHz			690		pF
C _{rss}	Reverse Transfer Capacitance			220		pF	
	NG CHARACTERISTICS (Note 1)	-			ı	1	
t _{D(on)}	Turn - On Delay Time	$V_{DD} = 30 \text{ V}, I_{D} = 60 \text{A},$			18	35	nS
t _r	Turn - On Rise Time	$V_{GS} = 5 \text{ V}, R_{GEN} = 10 \Omega$		430	600	nS	
t _{D(off)}	Turn - Off Delay Time	$R_{GS} = 10 \Omega$		63	120	nS	
t _f	Turn - Off Fall Time				240	400	nS
Q _g	Total Gate Charge	V _{DS} = 12 V			52	75	nC
Q_{gs}	Gate-Source Charge	$I_D = 60 \text{ A}, V_{GS} = 5 \text{ V}$			9		nC
Q_{gd}	Gate-Drain Charge			28		nC	

Symbol	Parameter	Conditions		Min	Тур	Max	Units
DRAIN-S	OURCE DIODE CHARACTERISTICS						
Is	Maximum Continuos Drain-Source Diod				60	Α	
I _{SM}	Maximum Pulsed Drain-Source Diode F			180	Α		
V_{SD}	Drain-Source Diode Forward Voltage	Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, I_S = 30 \text{ A} \text{ (Note 1)}$				1.3	V
			T _J = 125°C		8.0	1.2	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_F = 60\text{A},$	40		150	ns	
I _{rr}	Reverse Recovery Current	$dl_F/dt = 100 A/\mu s$				10	Α
THERMA	AL CHARACTERISTICS						
R _{øJC}	Thermal Resistance, Junction-to-Case			1.15	°C/W		
R _{OJA}	Thermal Resistance, Junction-to-Ambie			62.5	°C/W		

Note: 1. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2.0%.

Typical Electrical Characteristics

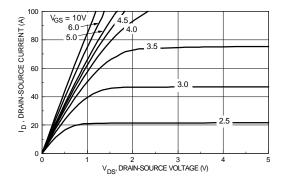


Figure 1. On-Region Characteristics.

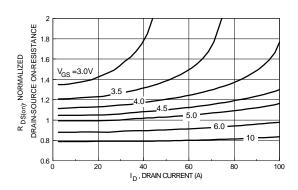


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

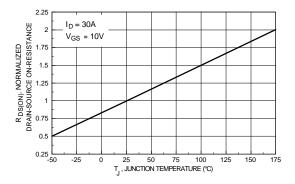


Figure 3. On-Resistance Variation with Temperature.

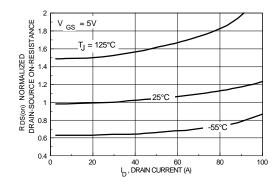


Figure 4. On-Resistance Variation with Drain Current and Temperature.

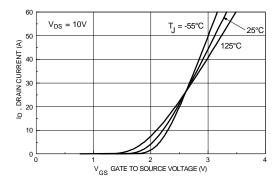


Figure 5. Transfer Characteristics.

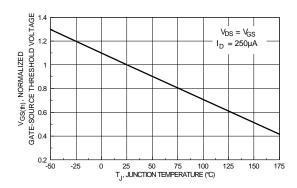


Figure 6. Gate Threshold Variation with Temperature.

Typical Electrical Characteristics (continued)

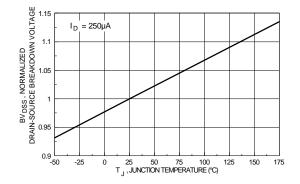


Figure 7. Breakdown Voltage Variation with Temperature.

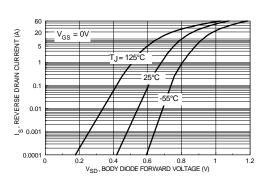


Figure 8. Body Diode Forward Voltage Variation with Current and Temperature.

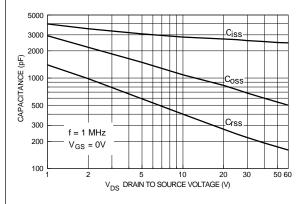


Figure 9. Capacitance Characteristics.

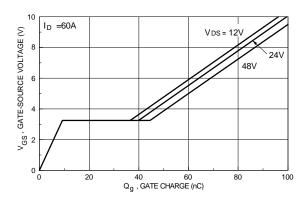


Figure 10. Gate Charge Characteristics.

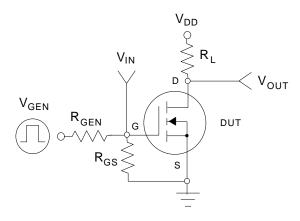


Figure 11. Switching Test Circuit.

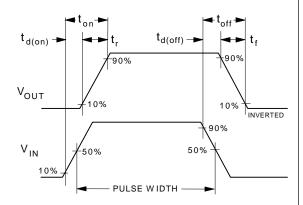
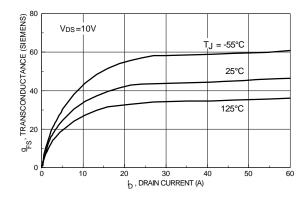


Figure 12. Switching Waveforms.

Typical Electrical Characteristics (continued)



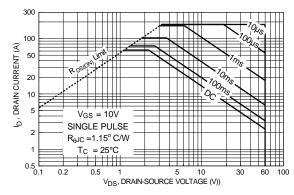


Figure 13. Transconductance Variation with Drain Current and Temperature.

Figure 14. Maximum Safe Operating Area.

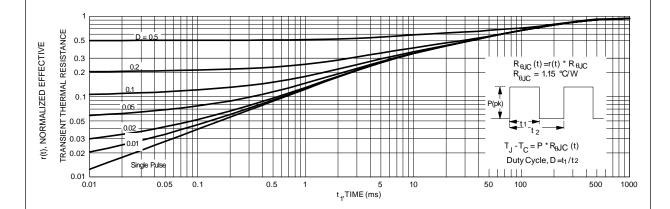
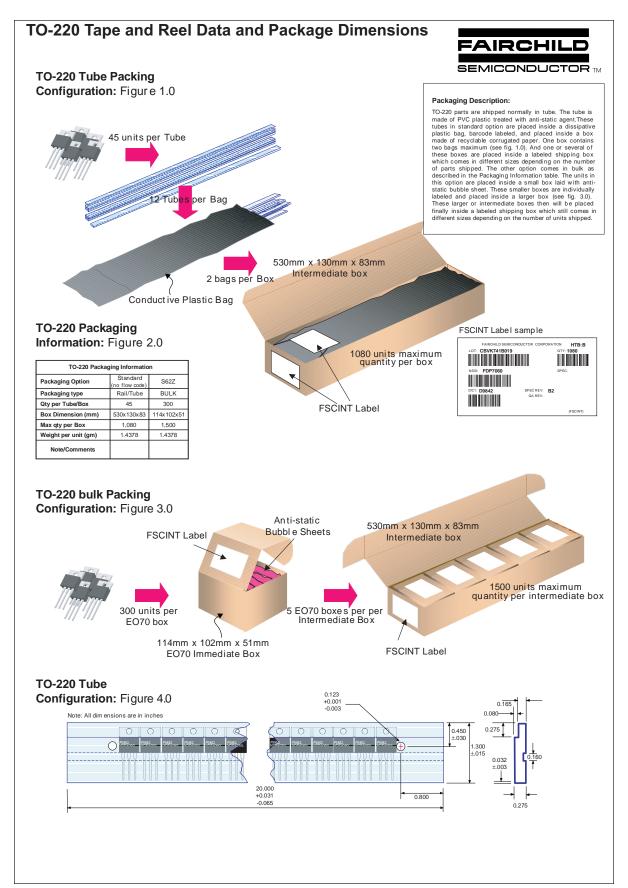
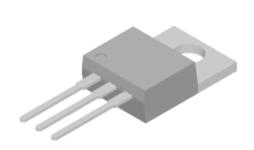


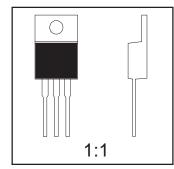
Figure 15. Transient Thermal Response Curve.



TO-220 Tape and Reel Data and Package Dimensions, continued

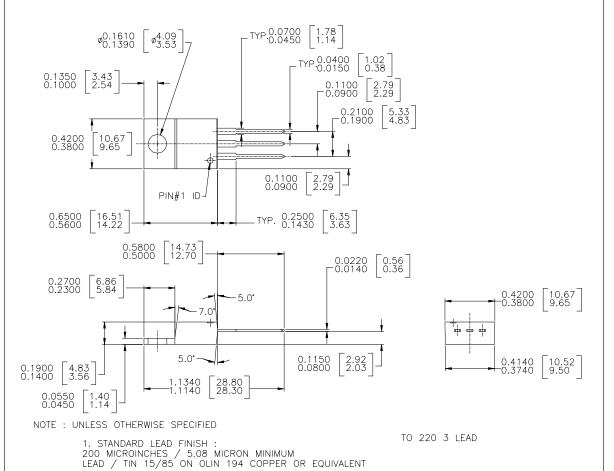
TO-220 (FS PKG Code 37)

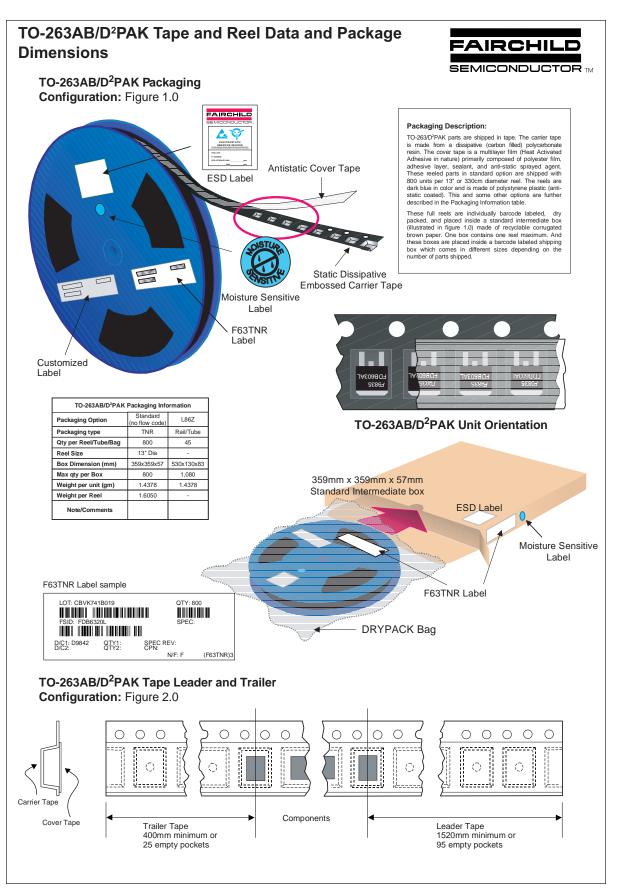




Scale 1:1 on letter size paper
Dimensions shown below are in:
inches [millimeters]

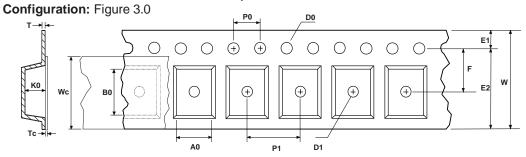
Part Weight per unit (gram): 1.4378





TO-263AB/D²PAK Tape and Reel Data and Package Dimensions, continued

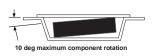
TO-263AB/D²PAK Embossed Carrier Tape



User Direction of Feed

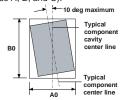
Dimensions are in millimeter														
Pkg type	Α0	В0	w	D0	D1	E1	E2	F	P1	P0	K0	Т	Wc	Тс
TO263AB/ D ² PAK (24mm)	10.60 +/-0.10	15.80 +/-0.10	24.0 +/-0.3	1.55 +/-0.05	1.60 +/-0.10	1.75 +/-0.10	22.25 min	11.50 +/-0.10	16.0 +/-0.1	4.0 +/-0.1	4.90 +/-0.10	0.450 +/-0.150	21.0 +/-0.3	0.06 +/-0.02

Notes: A0, B0, and K0 dimensions are determined with respect to the EIA/Jedec RS-481 rotational and lateral movement requirements (see sketches A, B, and C).



Sketch A (Side or Front Sectional View)

Component Rotation

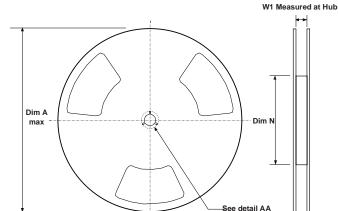


Sketch B (Top View)
Component Rotation

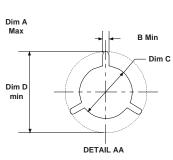


Sketch C (Top View)
Component lateral movement

TO-263AB/D²PAK Reel Configuration: Figure 4.0



13" Diameter Option



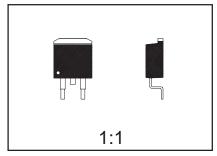
W2 max Measured at Hub

Dimensions are in inches and millimeters									
Tape Size	Reel Option	Dim A	Dim B	Dim C	Dim D	Dim N	Dim W1	Dim W2	Dim W3 (LSL-USL)
24mm	13" Dia	13.00 330	0.059 1.5	512 +0.020/-0.008 13 +0.5/-0.2	0.795 20.2	4.00 100	0.961 +0.078/-0.000 24.4 +2/0	1.197 30.4	0.941 - 0.1.079 23.9 - 27.4

TO-263AB/D²PAK Tape and Reel Data and Package Dimensions, continued

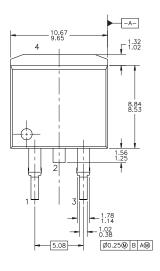
TO-263AB/D²PAK (FS PKG Code 45)

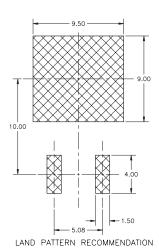


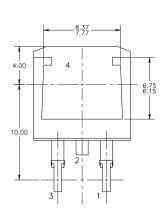


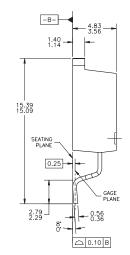
Scale 1:1 on letter size paper Dimensions shown below are in: inches [millimeters]

Part Weight per unit (gram): 1.4378









- NOTES: UNLESS OTHERWISE SPECIFIED

 A) ALL DIMENSIONS ARE IN MILLIMETERS.
 B) STANDARD LEAD FINISH:
 200 MICROINCHES / 5.08 MICROMETERS MIN.
 LEAD/TIN 15/85 ON OLIN 194 COPPER OR
 EQUIVALENT.
 C) MAXIMUM YERTICAL BURR ON HEATSINK NOT
 TO EXCEED 0.003 INCH / 0.05mm.
 D) NO PACKAGE CHIPS, CRACKS OR SURFACE
 IDENTIFICATION ALLOWED AFTER FORMING.
 E) REFERENCE JEDEC, TO—265, ISSUE C,
 VARIATION AB, DATED 2/92.

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